



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

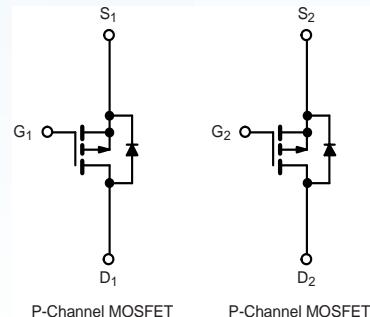
Product Specification

▶ Domestic Part Number	SI9948AEY
▶ Overseas Part Number	SI9948AEY
▶ Equivalent Part Number	SI9948AEY

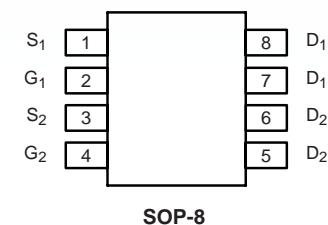


Dual P-Channel MOSFET**PRODUCT SUMMARY**

- V_{DS} (V) = -60V
- $R_{DS(ON)}$ < 59m Ω (V_{GS} = -10V)
- $R_{DS(ON)}$ < 69 m Ω (V_{GS} = -4.5V)

**APPLICATIONS**

Load Switches

**ABSOLUTE MAXIMUM RATINGS** $T_A = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 150^\circ\text{C}$)	$T_C = 25^\circ\text{C}$	I_D	A
	$T_C = 70^\circ\text{C}$		
	$T_A = 25^\circ\text{C}$		
	$T_A = 70^\circ\text{C}$		
Pulsed Drain Current	I_{DM}	- 32 ^e	
Continuous Source-Drain Diode Current	$T_C = 25^\circ\text{C}$	- 4.1	
	$T_A = 25^\circ\text{C}$	- 2.0 ^{a, b}	
Avalanche Current	I_{AS}	- 20	mJ
Single-Pulse Avalanche Energy	E_{AS}	20	
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	W
	$T_C = 70^\circ\text{C}$		
	$T_A = 25^\circ\text{C}$		
	$T_A = 70^\circ\text{C}$		
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, c}	R_{thJA}	38	50	°C/W
Maximum Junction-to-Foot	R_{thJF}	20	25	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. $t = 10$ s.
- c. Maximum under Steady State conditions is 85 °C/W.
- d. Based on $T_C = 25^\circ\text{C}$.
- e. Limited by package.

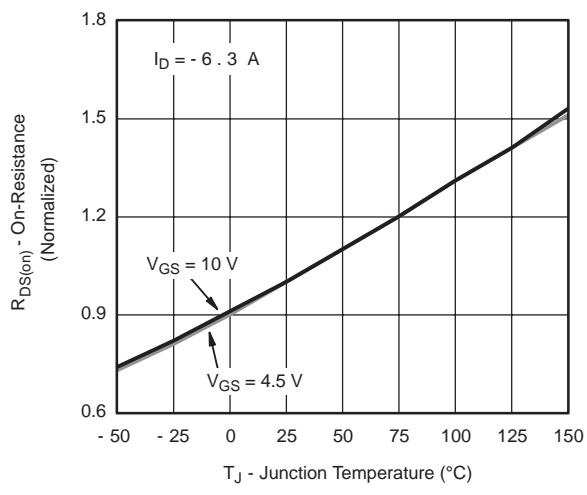
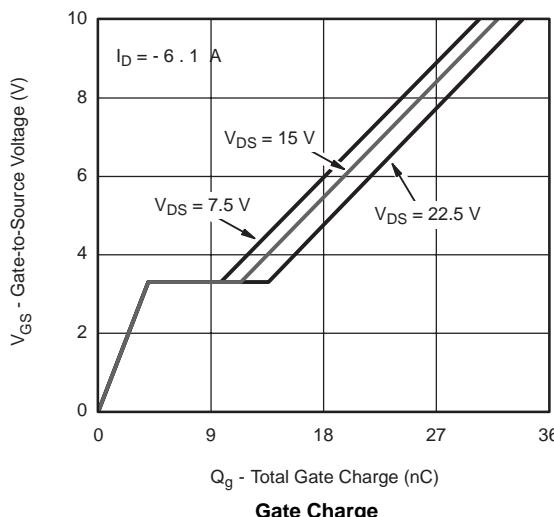
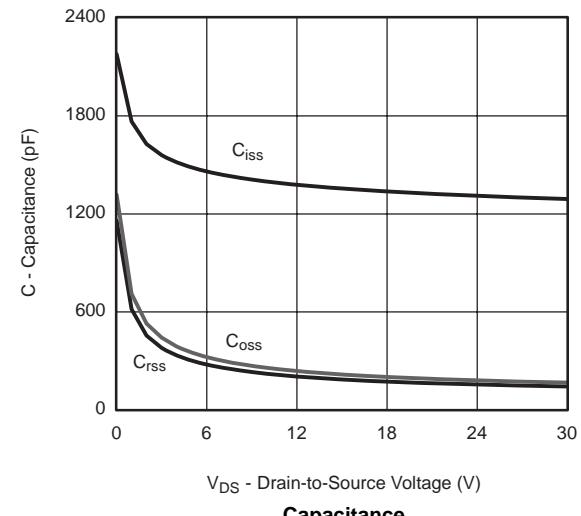
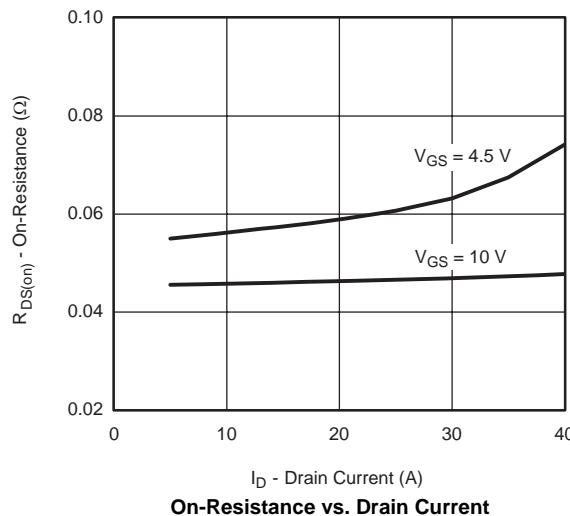
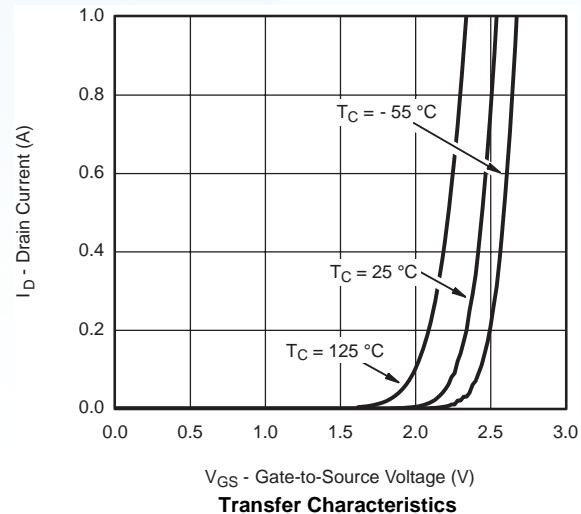
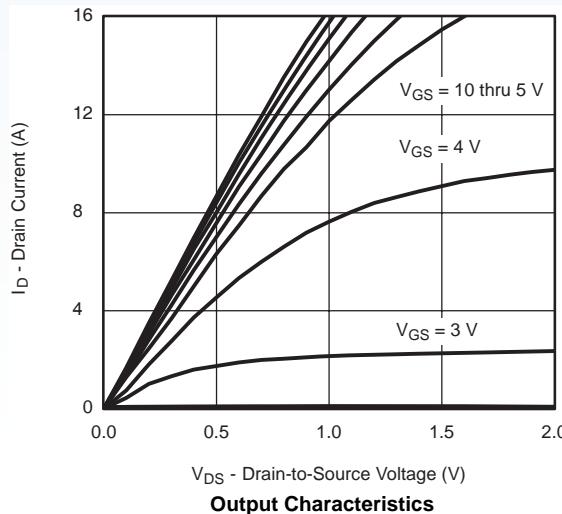
Dual P-Channel MOSFET

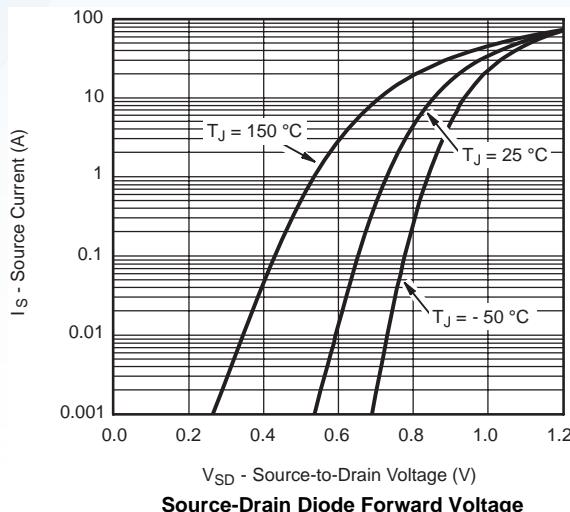
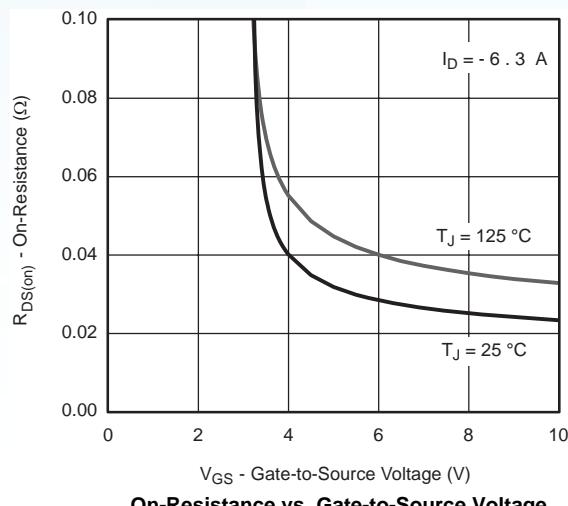
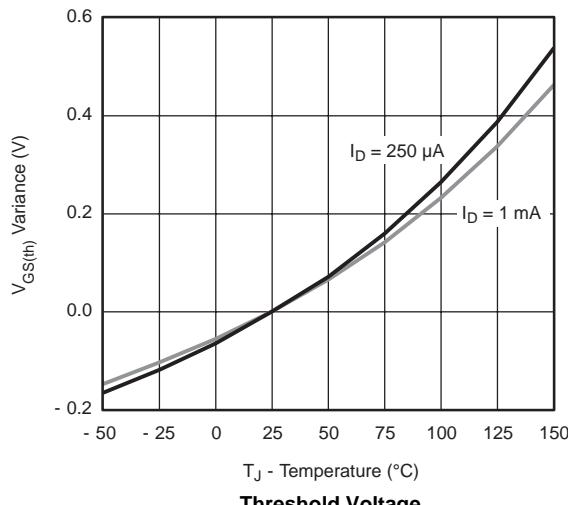
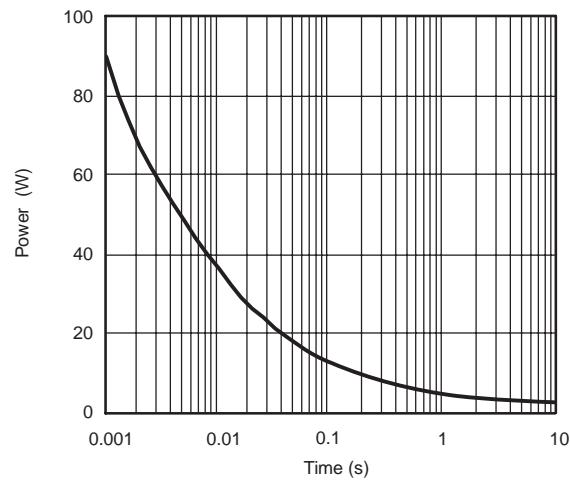
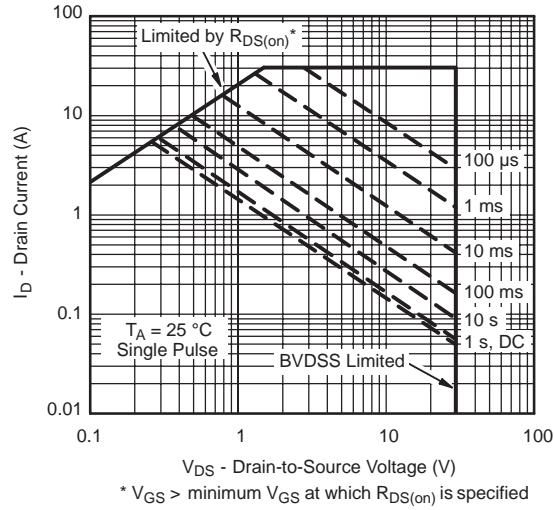
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

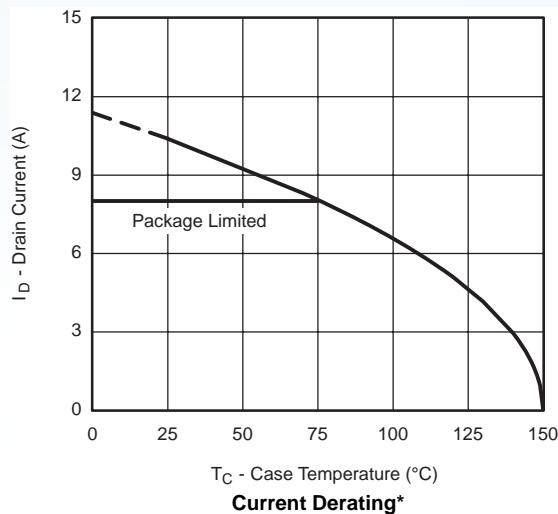
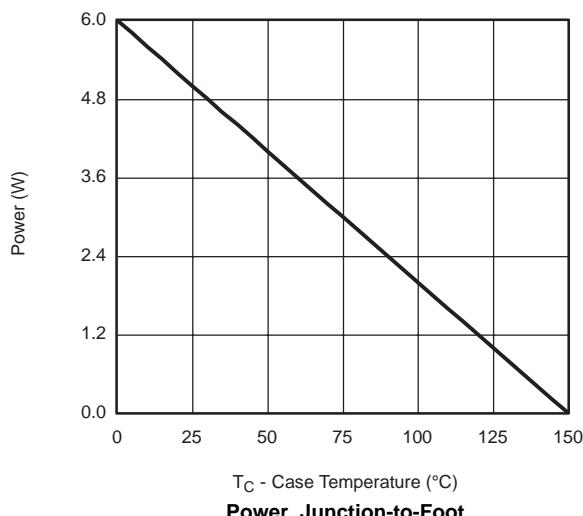
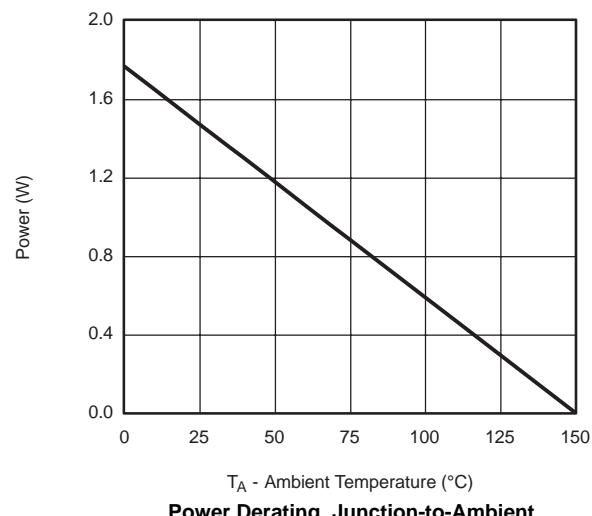
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu\text{A}$		- 31		mV/°C
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			4.5		
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	- 1.0		- 3.0	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μA
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$			- 5	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \geq -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			A
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = -10 \text{ V}, I_D = -6.3 \text{ A}$		54		mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -6.2 \text{ A}$		60		
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10 \text{ V}, I_D = -6.1 \text{ A}$		23		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1345		pF
Output Capacitance	C_{oss}			210		
Reverse Transfer Capacitance	C_{rss}			180		
Total Gate Charge	Q_g	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -6.1 \text{ A}$		32	50	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -6.1 \text{ A}$		15	25	
Gate-Drain Charge	Q_{gd}			4		
Gate Resistance	R_g			7.5		
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -15 \text{ V}, R_L = 15 \Omega$ $I_D \geq -1 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		5.8		Ω
Rise Time	t_r			10	15	ns
Turn-Off Delay Time	$t_{d(\text{off})}$			8	15	
Fall Time	t_f			45	70	
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -15 \text{ V}, R_L = 15 \Omega$ $I_D \geq -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		12	25	ns
Rise Time	t_r			42	70	
Turn-Off Delay Time	$t_{d(\text{off})}$			35	60	
Fall Time	t_f			40	70	
				16	30	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$			- 4.1	A
Pulse Diode Forward Current	I_{SM}				- 32	
Body Diode Voltage	V_{SD}	$I_S = -2 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -2 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$		34	60	ns
Body Diode Reverse Recovery Charge	Q_{rr}			22	40	nC
Reverse Recovery Fall Time	t_a			11		ns
Reverse Recovery Rise Time	t_b			23		

Notes:

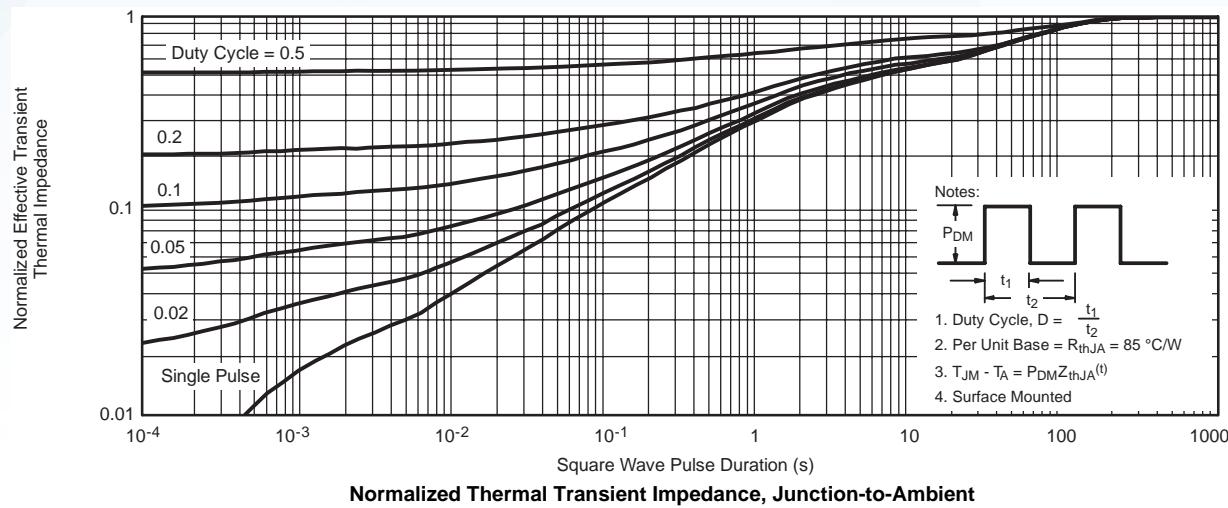
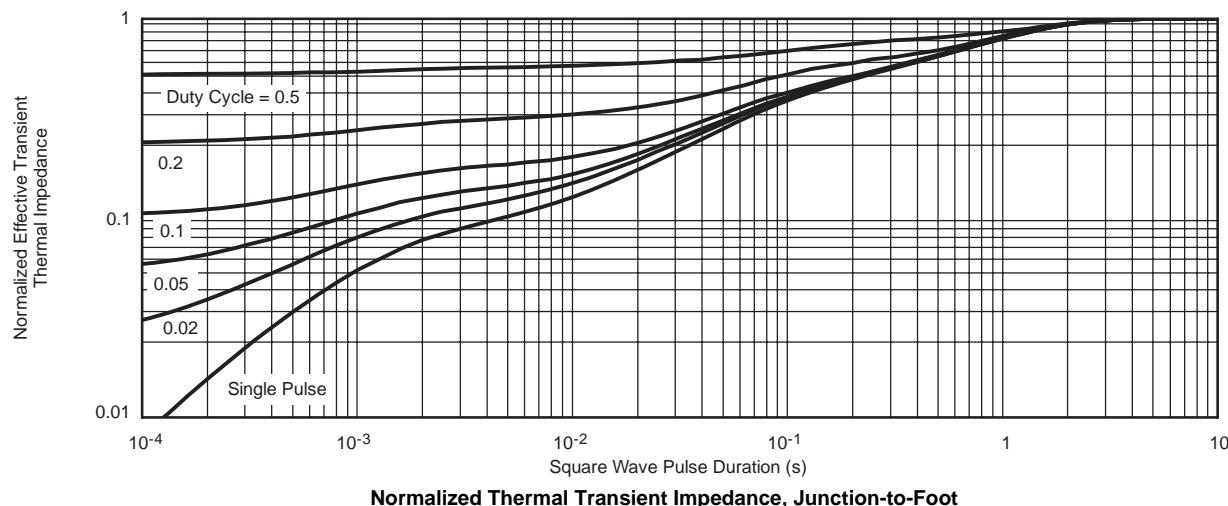
- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.

Dual P-Channel MOSFET
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


Dual P-Channel MOSFET
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area
 $* V_{GS} > \text{minimum } V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$

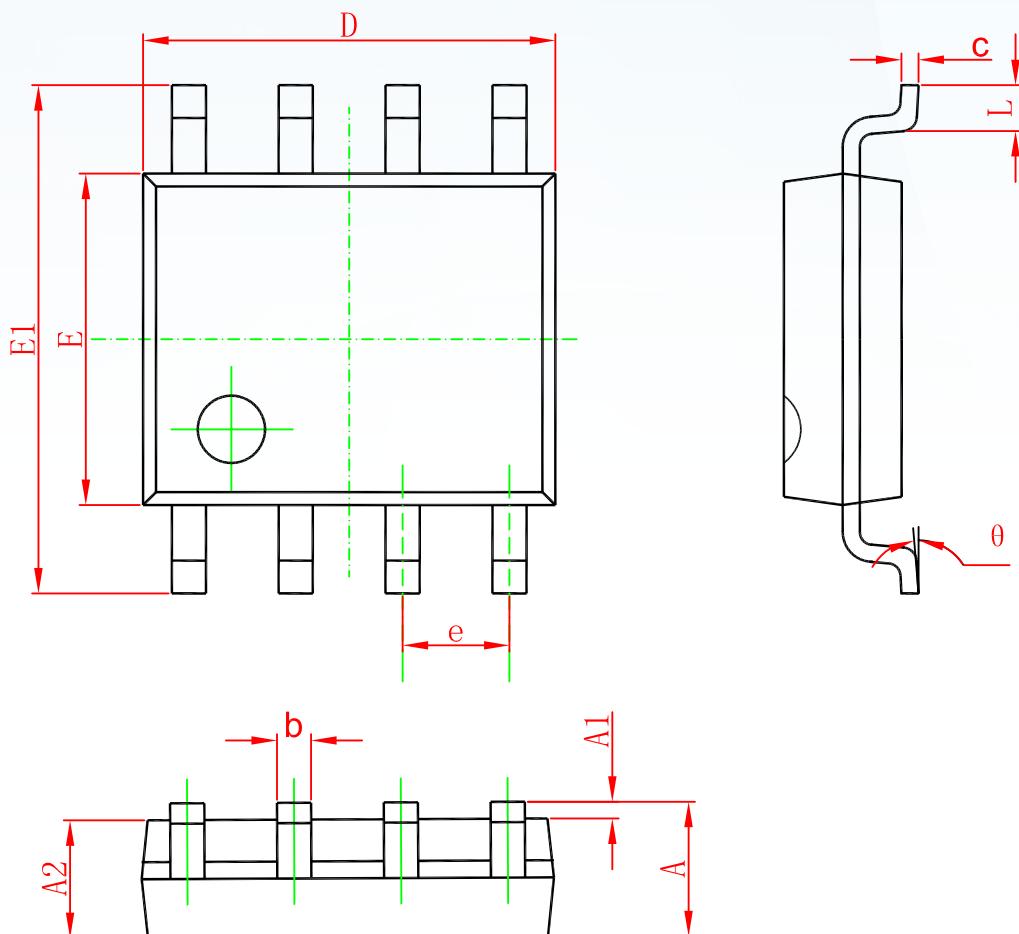
Dual P-Channel MOSFET
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted
**Current Derating***
Power, Junction-to-Foot
 T_C - Case Temperature (°C)

Power Derating, Junction-to-Ambient
 T_A - Ambient Temperature (°C)

The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

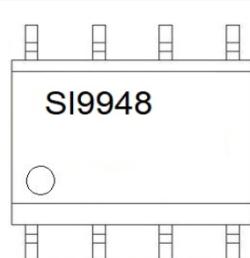
Dual P-Channel MOSFET
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Foot

Dual P-Channel MOSFET

SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

Dual P-Channel MOSFET**Marking****Ordering information**

Order code	Package	Baseqty	Deliverymode
SI9948AEY	SOP-8	3000	Tape and reel

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